

XPS and NEXAFS study of fluorine modified TiO₂ nano-ovoids reveals dependence of Ti³⁺ surface population on the modifying agent†

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Crystalline titanium dioxide was synthesised under mild conditions by the thermal degradation of peroxotitanic acid in the presence of a number of fluoride-containing surface modifying agents (NH₄F, NH₄BF₄, NH₄PF₆, NBU₄F, NBU₄BF₄, NBU₄PF₆). The resulting materials were characterised by PXRD, SEM, HRTEM, XPS and NEXAFS. Particle phase, size, and surface area were noticeably affected by the choice of surface modifying agent. Both the cation and anion comprising the modifying agent affect the surface Ti³⁺ population of the materials, with two apparent trends observed: F[−] > BF₄[−] > PF₆[−] and NBU₄⁺ > NH₄⁺. All materials displayed evidence of fluorine doping on their surfaces, although no evidence of bulk doping was observed.

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1 Introduction

Titanium dioxide (titania) is one of the most well-studied of the known photocatalysts¹ due to its wide band gap, chemical and biological inertness, non-toxicity, and commercial availability.² Since Fujishima and Honda's work demonstrating its photocatalytic activity,³ many researchers have focussed on developing the catalyst (particularly the anatase phase) for applications in a wide variety of fields, including photocatalytic air and water remediation,^{4–6} self-cleaning surfaces,⁴ photovoltaics,^{2,5,6} water splitting,^{5,6} and sensors.⁵ Nanosized titanium dioxide is of particular interest to researchers, due to its high surface area compared to macroscale catalyst. This allows for the exposure of orders of magnitude more active sites than would be available on bulk material.⁵

However, titanium dioxide exhibits three features that limit its usefulness as a photocatalyst:

(1) Its wide band gap limits light absorption to photons with energy >3.2 eV (for anatase),⁷ which represents a very small fraction of available solar light.⁸

(2) Photocatalytic efficiency is limited by the recombination of exciton pairs,² especially for doped or poorly-crystalline samples.

(3) Titanium dioxide nanocrystals thermodynamically favour low-energy crystal faces (the {101} face for anatase, for example), which are less catalytically active than higher-energy faces.⁹

Much recent research has focussed on the mitigation of these drawbacks. Anion doping has recently seen use as a means of narrowing the anatase band gap by introduction of mid-gap states; the popularity of this technique should be attributed to Asahi *et al.* for their work on nitrogen-doping of titania.¹⁰ Recombination events can be limited either by increasing the crystallinity of the catalyst (for example, through high-temperature treatment)¹¹ or by encouraging charge separation.¹² The industrial catalyst Aeroxide P-25, for example, may discourage recombination events by the inclusion of rutile-phase titania, which acts as an electron trap and efficiently separates charge.¹²

The problem of facial selectivity in titanium dioxide nanocrystal growth (particularly in the case of the sol-gel synthetic pathway) was recently addressed by Lu *et al.*, who showed that the fluoride ion would preferentially bind to the high-energy anatase {001} face.⁹ In this way the fluoride acted as a surface modifying agent (SMA) and encouraged the growth of this crystal face even under mild conditions. Surface-bound fluoride has also been shown to decrease charge recombination by acting as an electron trap,¹³ and may even narrow the titania band gap when used as a dopant.¹⁴ Thus, titanium dioxide synthesis in the presence of fluoride shows excellent promise as a means of addressing the problems currently faced in sol-gel titanium dioxide synthesis.

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While the breakthrough paper by Lu *et al.* paved the way for a number of studies on the synthesis of high-energy titania nanocrystals,^{15–22} their original work (and many follow-up papers) focussed on the use of toxic and highly dangerous hydrofluoric acid as a fluoride source, combined with high-pressure/high-temperature synthetic conditions. Some researchers (notably Yu *et al.*²³) have shown similar results using ionic liquids, which are considerably more complex than the relatively simple fluoride sources used previously. Only very recently have researchers focussed on simpler and less toxic sources of fluoride or fluoride-containing species.^{24–33} To the authors' knowledge, there currently exists no systematic study of such fluoride sources and their effects on the synthesis of titanium dioxide nanoparticles.

Here we present a study of the effect of a number of fluoride-containing salts (NH_4F , NH_4BF_4 , NH_4PF_6 , NBu_4F , NBu_4BF_4 , NBu_4PF_6) on the synthesis of crystalline titanium dioxide nanoparticles *via* the thermal degradation of peroxotitanic acid under mild conditions. We have purposefully selected a wide range of fluoride-containing surface modifying agents to gauge the effect not only of the fluoride source (F^- , BF_4^- , PF_6^-) but also of the cation (NH_4^+ , NBu_4^+) on the formation of titanium dioxide nanoparticles. While some of these salts (*i.e.* NH_4F ,^{25,27,34} NH_4BF_4 ²⁶) have seen previous use in literature, the majority of the modifying agents used in this study have not been tested previously. We report the effect of SMA on particle size, crystallinity and surface area, as well as Ti^{3+} population.

2 Results and discussion

2.1 Particle sizing

As-prepared materials were characterised by scanning electron microscopy (SEM) and dynamic light scattering (DLS) to determine particle size. A minimum of 200 particles were analysed for each sample for SEM particle size counting. Particle sizes are shown in Fig. 1, sample SEM images of particles are shown in

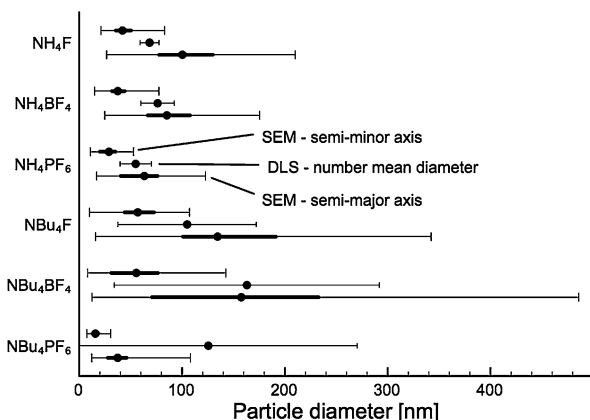


Fig. 1 Particle diameter measured along the semi-major and semi-minor axes, as well as average particle diameter measured by DLS. For SEM particle sizing, the thin line indicates the full range of particles counted, the thick line the upper and lower quartiles, and the central dot the median value. For DLS the dot indicates the number-mean particle size and the error bars the 95% confidence interval.

Fig. 2 (for comparison SEM image of titania synthesised in the absence of SMA, see Fig. S1†).

All products were found to be ovoid nanoparticles, with a mean anisotropy (calculated by SEM particle sizing) of 0.40–0.49. DLS data generally agreed with SEM particle sizes, except for NBu_4PF_6 -modified TiO_2 . The presence of NBu_4PF_6 on the surface of the particles likely encourages their aggregation in solution, giving rise to a much larger apparent size by DLS.

While particles synthesised in the presence of F^- and BF_4^- appear to have approximately the same size, particles synthesised in the presence of PF_6^- are much smaller. Of note, there appears to be a considerable difference in size between NH_4BF_4^- and NBu_4BF_4 -modified TiO_2 . Specifically, particles synthesised in the presence of NBu_4 -containing SMAs are much more polydisperse. This indicates that particle size is dependent not only on the anionic group, but also on the cationic group of the SMA.

2.2 Surface area measurements

Surface area measurements (BET isotherm) are shown in Fig. 3. All samples exhibited type 4 isotherms, with some small hysteresis suggesting larger pores (adsorption curves shown in Fig. S2†).

2.3 Crystallinity

High-quality PXRD patterns were collected at the powder diffraction beamline at the Australian Synchrotron. Full-pattern fitting analysis of PXRD data showed that all products were crystalline, and generally formed the anatase phase of titania (Fig. 4): in fact, materials synthesised in the presence of NH_4^+ -containing surface modifying agents showed no rutile or brookite content. Titanium dioxide synthesised by a similar manner in the absence of fluoride ions (Fig. S3†) forms a roughly 28 : 72 mixture of anatase and rutile. Yu and coworkers³⁵ have previously observed this effect, and argued that the presence of fluoride may either prevent phases other than anatase from forming (due to preferential binding) or may encourage the phase transformation to anatase. For NBu_4^+ -SMA-modified materials, rutile and even brookite were observed (see Table 1 for exact amounts). If it is assumed that phase selectivity is due to the presence of SMA, the presence of these phases suggests that in the case of NBu_4^+ -SMAs, the anion is not as influential as the cation in the formation of the nanoparticle.

The titanium occupancy was allowed to vary during the Rietveld refinement. In most cases the titanium occupancy of the materials was less than one, *i.e.* the crystal lattice was titanium deficient. Titanium-deficient titanium dioxide has previously been attributed to the presence of OH^- ions within the bulk.³⁷ Given the use of H_2O_2 in the synthesis of the products reported here, it is feasible that OH^- groups would be trapped within the lattice, resulting in a lower-than-expected titanium occupancy. The titanium occupancy within the anatase phase was approximately 0.82 for all NH_4^+ -SMA-modified products and 0.89 for NBu_4^+ - TiO_2 . The small difference in Ti deficiencies between the two cation types of SMAs suggests the Ti deficiency



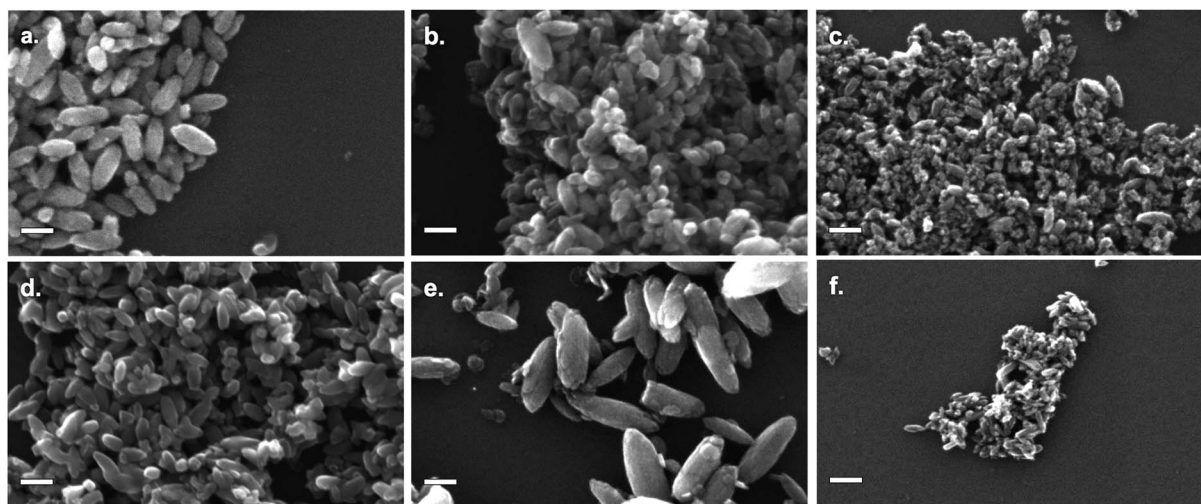


Fig. 2 SEM images of TiO_2 modified by: (a) NH_4F ; (b) NH_4BF_4 ; (c) NH_4PF_6 ; (d) NBu_4F ; (e) NBu_4BF_4 ; (f) NBu_4PF_6 . All scale bars are 100 nm.

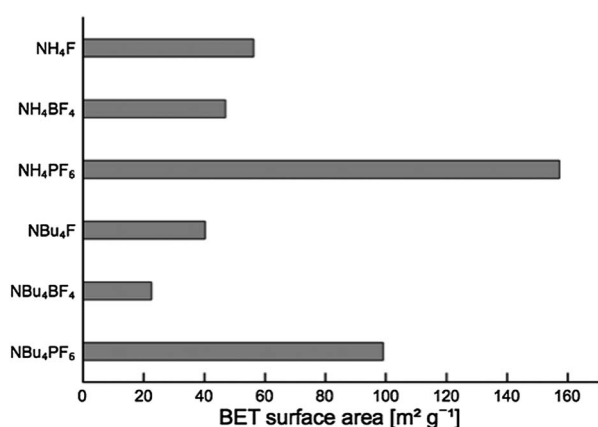


Fig. 3 BET surface areas for TiO_2 modified by different fluoride-containing surface modifying agents.

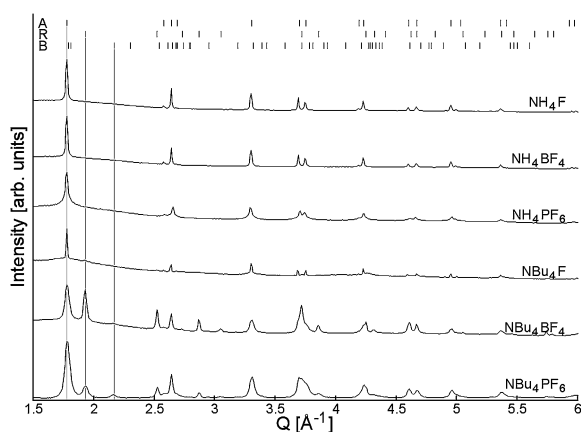


Fig. 4 PXRD diffraction patterns for TiO_2 modified with fluoride salts. Anatase, rutile and brookite theoretical peak positions are shown at the bottom of the graph. The abscissa is given in momentum transfer units $Q = 4\pi \sin(\theta)/\lambda$.

is only partially dependent on the SMA but mostly due to the peroxo-titanic acid hydrothermal synthesis. Rutile in $\text{NBu}_4\text{BF}_4\text{-TiO}_2$ and $\text{NBu}_4\text{PF}_6\text{-TiO}_2$ exhibited titanium occupancy of 0.88: very similar to the majority of anatase phase crystallites, suggesting again that deficiencies in Ti are related to synthesis conditions rather than the SMA.

Size and microstrain analysis of the PXRD data by Rietveld refinement (Fig. S4†) shows that a majority of the products are anisotropic in shape. All samples except $\text{NH}_4\text{PF}_6\text{-TiO}_2$ show preferential orientation for both anatase and rutile in the [001] direction, and are also anisotropically elongated in this direction. Additionally, the anatase (004) peak is both larger and narrower than expected from shape- and direction-isotropic modelling of a population of the same crystallite size. These peak profiles are best explained by rod-like crystallites oriented along the [001] direction. The larger area is explained by the preferred orientation, and the sharper line profile is explained by increased crystallinity along the major planes of the rod (see Fig. S5†). As can be seen in Table 1 the addition of SMA produced anatase crystallites that were elongated in the [001] direction for all cases except $\text{NH}_4\text{PF}_6\text{-TiO}_2$. The dimensions observed in SEM and those calculated from PXRD data largely agree. The exception is $\text{NBu}_4\text{BF}_4\text{-TiO}_2$, whose ovoid particles (observed in SEM) have dimensions far larger than those determined by PXRD. It is likely that the observed particles consist of multiple grains.

For $\text{NH}_4\text{PF}_6\text{-TiO}_2$, the PXRD data was best modelled by two isotropic (in shape and direction) anatase populations, one population of diameter ~ 3.3 nm and another larger population of diameter 19.8 nm. The larger anatase population showed no preferred crystallite orientation, although in SEM the larger particles appeared elongated (Fig. 2C). The aggregation of smaller particles around the larger particles could have prevented them from preferentially orienting, or alternatively the observed particles may not be single crystallites. The rutile phase titania also showed rod-like character and exhibited preferential orientation (however, for $\text{NBu}_4\text{F-TiO}_2$ particle



Table 1 The weights of phases and crystallite dimensions as calculated from a Rietveld refinement fitting anatase, brookite and rutile phases for each SMA. Percentage weight of phases was determined by the Rietveld refinement and size was calculated from a volume weighted mean column height of a Double-Voigt fit.³⁶ Error indicates 99% C.I.

| SMA | Anatase | | Rutile | | Brookite | |
|----------------------------------|--------------|-------------------------|--------------|-------------------------|--------------|------------------------|
| | Fraction [%] | Dimensions [nm] | Fraction [%] | Dimensions [nm] | Fraction [%] | Dimensions [nm] |
| NH ₄ F | 100 | 28.7 ± 1.3 × 119 ± 12 | | | | |
| NH ₄ BF ₄ | 100 | 27.2 ± 1.2 × 90 ± 9 | | | | |
| NH ₄ PF ₆ | 49 ± 4 | 19.8 ± 0.7 ^a | | | | |
| | 51 ± 4 | 3.3 ± 0.2 ^a | | | | |
| NBu ₄ F | 76 ± 3 | 70 ± 8 × 200 ± 30 | 24 ± 3 | 13 ± 2 ^a | | |
| NBu ₄ BF ₄ | 48.5 ± 1.6 | 11.8 ± 0.7 × 40 ± 3 | 43.6 ± 1.0 | 16.8 ± 0.6 × 38.3 ± 1.4 | 7.9 ± 0.9 | 8.8 ± 1.2 ^a |
| NBu ₄ PF ₆ | 57.2 ± 1.4 | 10.9 ± 0.5 × 34.1 ± 1.7 | 22.4 ± 1.1 | 8.2 ± 0.8 × 20.9 ± 0.8 | 20.5 ± 0.9 | 6.8 ± 0.4 ^a |

^a Sample is isotropic in shape.

shape could not be determined due to the lack of definition in rutile peaks). This rod-like form is typical of rutile grown in an acidic environment.^{38,39}

HRTEM studies further confirmed the particle size and shape model developed based on SEM and PXRD data, demonstrating strong fringing patterns (Fig. 5) indicative of crystalline material. Ovoid particles exhibited strong fringing indicative of the [101] plane, at approximately 45° to their long edge, suggesting that their shape was dictated by the growth of specific crystal faces. Based on this data, it is proposed that the (010) face is located on the long edge of the nanoparticle (Fig. 6).⁴⁰ It should be noted that many smaller particles do not follow this pattern: these particles appear more regularly in products synthesised using NBu₄-containing SMAs.

2.4 Electron spectroscopy studies

X-ray photoelectron spectroscopy (XPS) was performed at the soft X-ray beamline of the Australian Synchrotron.⁴¹ Survey scans (see ESI, Fig. S6†) showed evidence of silicon (from the wafer), carbon, titanium, oxygen, nitrogen, and fluorine, with boron and phosphorus observed for BF₄[−] and PF₆[−]-modified materials (ESI, Fig. S7†). High-resolution XPS was performed on the fluorine 1s, titanium 2p, nitrogen 1s, oxygen 1s and carbon 1s peaks, as well as the phosphorus 2p peak for PF₆[−]-modified

samples. Peak positions, intensities, and FWHMs are tabulated in ESI, Tables S1 and S2.†

Two oxygen 1s peaks were observed (see Fig. 7 for a typical O 1s XP spectrum). The peak at ~532.5 eV was assigned to surface Ti–O–H and SiO₂, while the one at ~530 eV were assigned to Ti–O–Ti.⁴² In all cases the Ti : O ratio by XPS was approximately 1 : 2, suggesting that any deviation in occupancy levels in the bulk did not continue to the surface of the material.

The presence of fluoride was confirmed by XPS (Fig. 8, fluorine populations for all samples shown in ESI, Fig. S8†). Two peaks were observed: a broad peak at 687–688 eV (A) and a sharper one at 684–685 eV (B). All samples exhibited this double-peak feature, despite being washed several times with distilled water (and additionally with acetonitrile for tetrabutylammonium salt-modified samples), indicating that the SMA was strongly bound to the surface. While fluorine peaks in the region of peak A have previously been attributed to surface

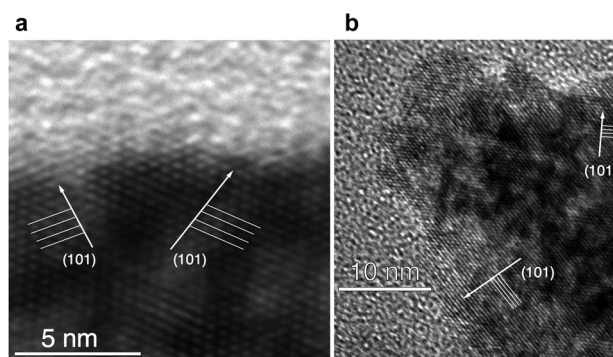


Fig. 5 HRTEM fringing from the (101) face of fluorine-modified TiO₂ proceeds at ~45° to the long edge of the nanoparticle. (Shown here: TEM image of NH₄F–TiO₂.)

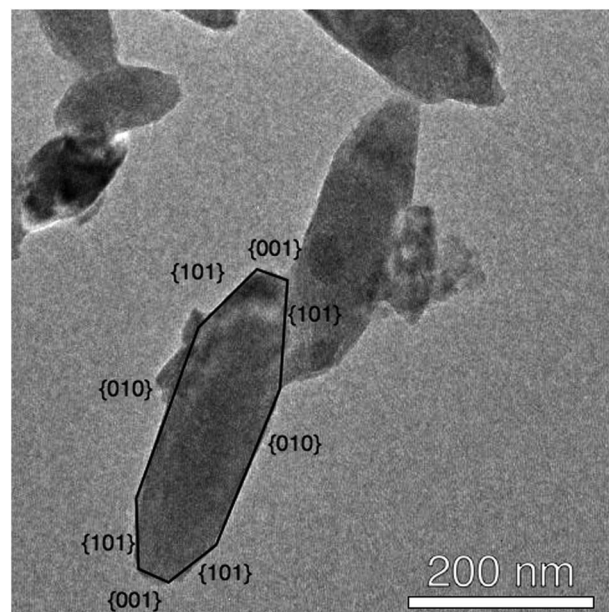


Fig. 6 The proposed structure of nanocrystalline TiO₂. (Shown here: NBu₄F–TiO₂.)



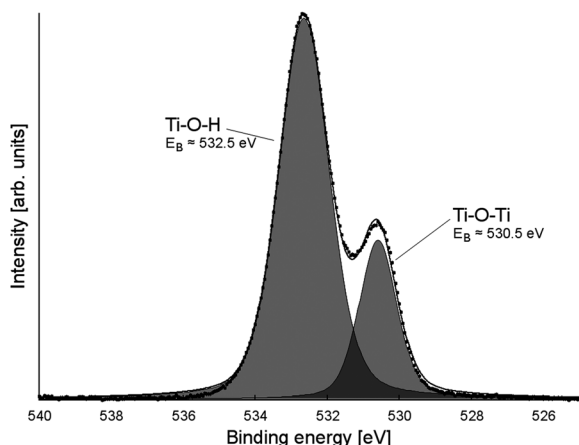


Fig. 7 A typical O 1s XPS spectrum (shown here: $\text{NH}_4\text{F-TiO}_2$), with peak assignments.

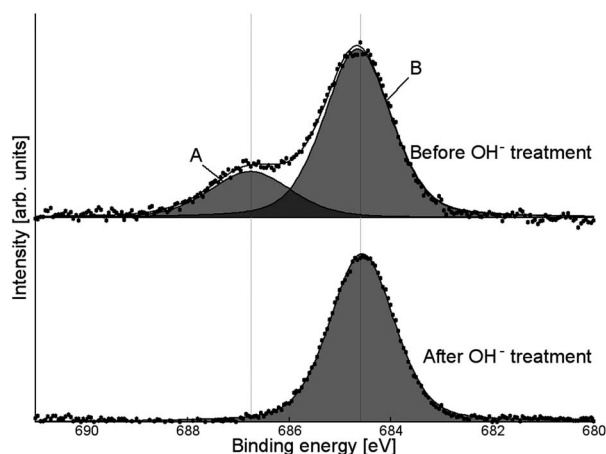


Fig. 8 High-resolution F 1s XPS signal for NH_4PF_6 -modified TiO_2 , before and after washing with KOH.

lattice fluoride (Ti-F-Ti),^{13,26,43–45} it was found that this peak could be removed by treatment with KOH solution (1 M, one hour; Fig. 8). This suggests that the fluoride species is more likely to be surface-bound, as lattice fluorine has previously been reported to be stable to base treatment.⁴³ Additionally, a small carbon XPS peak (see ESI, Fig. S9†) is observed to disappear after KOH treatment: this peak may be attributable to fluorocarbon species.⁴⁶ Peak B is assigned to surface-bound, chemisorbed Ti-F groups based on its binding energy position.^{13,43,44} However, KOH treatment does not remove the species giving rise to peak B, although washing with less concentrated base solutions^{16,47} has previously been shown to remove chemisorbed Ti-F groups. The reason for the stability of this species even under basic conditions is as yet unknown.

Analysis of the titanium XPS signal (see ESI, Fig. S10† for full fitting) shows a characteristic peak at 459 eV attributed to Ti^{4+} , with a smaller peak around 457.7–458 eV indicative of surface Ti^{3+} . The Ti^{3+} peak is visible even for untreated P-25 (where it is approximately 1% of the total Ti signal), which has been found

before on unmodified TiO_2 nanoparticles,⁴⁸ anatase nanotubes,⁴⁹ and doped nanotubes.⁵⁰ On titania single crystals, Ti^{3+} has been found after ion bombardment.^{51,52} The Ti^{3+} sites at the surface of the nanoparticles, nanotubes and doped nanotubes are stable in air.^{48–50} For those created by ion bombardment on single crystal surfaces the ref. 51 and 52 do not report whether or not the Ti^{3+} states induced by ion bombardment are stable in air. In all cases, the Ti^{3+} surface content for SMA-modified TiO_2 (as a function of total Ti content, see Fig. 9) was greater than for P-25. This is likely due to the effect of the surface-bound fluoride, which has been previously shown to encourage Ti^{3+} formation.⁴²

$\text{NBu}_4\text{F-TiO}_2$ shows the greatest Ti^{3+} surface concentration, with the Ti^{3+} XPS signal comprising 7% of the total Ti XPS signal. The exact concentration in any of the layers cannot be determined from a single measurement, however, it is possible to estimate the upper limit for the Ti^{3+} concentration. Assuming an electron mean free path of 0.38 nm (based on the calculations of Fuentes *et al.*,⁵³ given $E_{\text{kin}} = 360$ eV as used for the XPS measurements), 16% of total Ti population of the surface is in the +3 oxidation state in case that Ti^{3+} is only present in the first monolayer. In this calculation one monolayer is considered as a layer with the thickness of the *a*-axis of the unit cell of anatase (0.38 nm). Assuming that Ti^{3+} is distributed equally over the first two or three monolayers, the Ti^{3+} concentration is calculated to be 10% and 9%, respectively. The estimates provided above are solely for the purpose of gauging the upper limit of the Ti^{3+} concentration at the material surface, and are not meant as a model for the distribution of Ti^{3+} . For determining the distribution of Ti^{3+} more accurately, XPS measurements over a large range of excitation energies would have to be acquired.

While such a population is considerably higher than that of unmodified TiO_2 , it is still much lower than could be achieved by, for example, Ne^+ ion bombardment, which has been shown to achieve a Ti^{3+} surface concentration of up to 45%.⁵²

In addition, there is an apparent correlation between both anionic and cationic group of the SMA, and the abundance of Ti^{3+} in the material (*i.e.* $\text{F}^- > \text{BF}_4^- > \text{PF}_6^-$; $\text{NBu}_4^+ > \text{NH}_4^+$). The presence of these Ti^{3+} centres may improve visible light activity

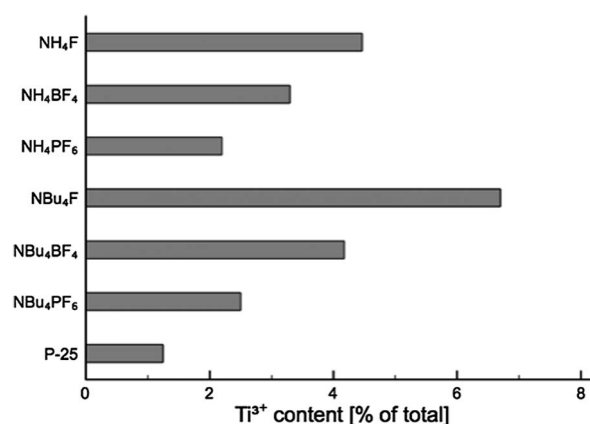


Fig. 9 Ti^{3+} content (as a percentage of total Ti content) for each product.



through the creation of localised mid-gap states,^{54,55} aiding in the visible-light activity of the materials.

NEXAFS analysis was performed on the Ti $L_{2,3}$ transition using Auger and Total Electron Yield (AEY and TEY) and Fluorescence Yield (FY) measurements. Typical AEY, TEY and FY NEXAFS spectra are shown in Fig. 10, and full graphs are available in ESI (Fig. S11†). The AEY spectrum was found to be the most well-defined, with TEY and FY exhibiting less signal. In a majority of cases the edge displays a characteristic shape, with auxiliary peaks marked A and B and main peaks C–G. Peak assignments based on literature reports are shown in Table 2.^{56,57}

The properties of these peaks (*e.g.* relative intensities, splitting) may be altered by the presence of dopants in the bulk titania crystal matrix.⁵⁷ Two particular trends are of interest here:

- The ratio between the peaks C and D is strongly dependent on the crystal phase of the titanium dioxide material, due to long-range structural effects.⁵⁸ Anatase materials exhibit a strong C and somewhat weaker D peak, while rutile displays the converse.

- The presence of pentacoordinate Ti^{3+} sites within the bulk of the material results in a greatly decreased intensity in the relative intensities I_C/I_D and I_F/I_G , as well as the appearance of a shoulder peak on the low-energy side of peak F.^{59,60}

It can be seen that for NH_4^+ -SMA-modified TiO_2 the low-energy peak C is significantly more intense, and the high-energy peak D is apparent only as a shoulder for all scans. For NBu_4F^- and $NBu_4PF_6^-$ -modified TiO_2 , the high-energy peak is more apparent: this is a result of the presence of significant quantities of rutile in the material, which correlates with the PXRD findings above.

It is also interesting to compare the above-mentioned ratios measured using electron and fluorescence yield. Electron yield NEXAFS is generally sensitive to only the top 50 Ångstroms of the material, while fluorescence yield measurements may penetrate as far as 500–1000 Ångstroms into the bulk.^{61,62} Thus, comparison of data collected using these techniques allows for a more comprehensive view of the change in particle properties

Table 2 Peak assignments for Ti $L_{2,3}$ NEXAFS spectra

| Peak | Assignment |
|------|----------------|
| A | Satellite peak |
| B | Satellite peak |
| C | $t_{2g} L_3$ |
| D | $e_g L_3$ |
| E | $e_g L_3$ |
| F | $t_{2g} L_2$ |
| G | $e_g L_2$ |

with depth. Graphs of the intensity ratios I_C/I_D and I_F/I_G are shown in Fig. 11, and it can immediately be seen that both these ratios increase slightly under FY as compared to AEY and TEY. This suggests that Ti^{3+} centres are concentrated at the surface of the material, and are considerably less prevalent in the bulk. The only deviations from this pattern are observed for I_F/I_G in NBu_4F and I_C/I_D for NBu_4PF_6 , in which the FY signals are rather weak.

2.5 Surface charge

Zeta potential measurements were performed on all samples, without KOH treatment as discussed above (ESI, Fig. S12†). The

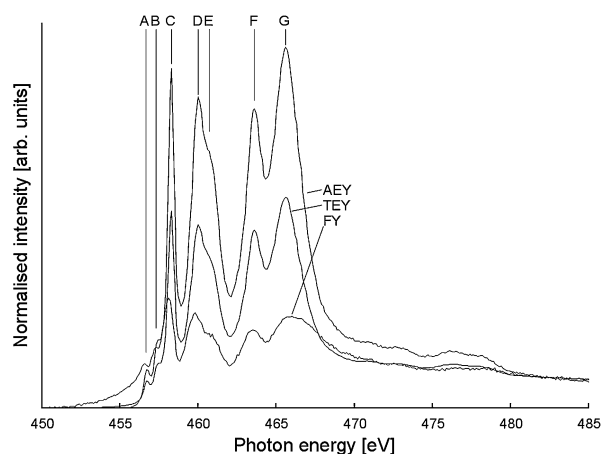


Fig. 10 Typical Ti $L_{2,3}$ NEXAFS spectrum (here: NH_4F-TiO_2). Peaks referred to in the main text are labelled, and AEY, TEY and FY curves are noted.

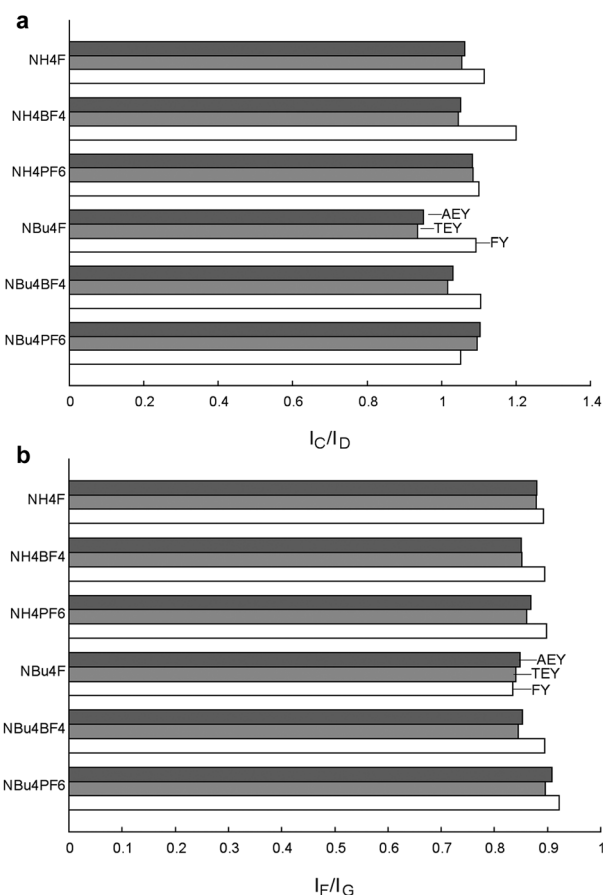


Fig. 11 Ratios of NEXAFS peak intensities for fluorine-modified TiO_2 materials. Anomalous measurements for NBu_4F-TiO_2 are due to poor FY data, see ESI Fig. S11† for individual spectra.



majority of fluoride-modified materials show a negative zeta potential, the two exceptions being $\text{NBu}_4\text{BF}_4^-$ and $\text{NBu}_4\text{PF}_6^-$ -modified TiO_2 . In contrast, TiO_2 synthesised in the absence of SMA shows a positive zeta potential. This change in zeta potential is attributed to the fluorinated surface of the modified materials, while the variation in zeta potential suggests that not all SMAs are equal in their ability to influence the surface of the material.

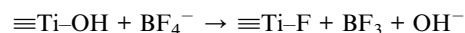
There is no correlation between XPS measurements of fluoride intensity (normalised by total Ti signal) and zeta potential. This may be due to the differing preparation methods and media for the two techniques (*i.e.* measurement in solution at atmospheric pressure as opposed to measurement of the solid under UHV conditions).

2.6 Mechanism of growth

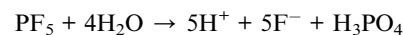
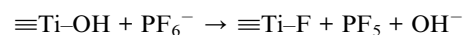
The above results demonstrate that the choice of SMA heavily influences particle size, crystallinity, surface area and electronic structure of the product. In solution, fluoride (F^-) will bind strongly to titanium, forming Ti-F. The presence of fluoride bound to titanium during synthesis encourages the growth of anatase (as opposed to rutile) titania;³⁵ this suggests that those materials that exhibit rutile and brookite character are exposed to lower concentrations of fluoride during synthesis. Pure anatase materials exhibited a much larger (004) PXRD peak than predicted by the spherical particle model, which correlated with SEM and TEM observations of anisotropy. This further suggests that the SMA is responsible for alterations in both particle size and particle phase.

XPS studies show that fluoride is chemically bound to the TiO_2 surface as Ti-F, not as Ti-BF_4 or Ti-PF_6 . Previous reports are inconclusive on the nature of BF_4^- -SMA modification: Zhou and coworkers recently reported that TiO_2 synthesised in acidic NaBF_4 solution was modified by the BF_4^- ion, citing evidence of Ti-B-F species in B XPS;²⁸ other groups have reported that

NaBF_4 dissociates to give surface Ti-F as an SMA.^{26,63} It is posited that in the synthetic method outlined in this report, BF_4^- decomposes to give free fluoride in addition to boric acid (here “ $\equiv\text{Ti}$ ” represents surface-bound titanium):



PF_6^- has been reported to decay in a similar manner to give F^- .⁶⁴ We therefore propose a similar mechanism for PF_6^- in solution:



This mechanism is schematically illustrated in Fig. 12. An increase in temperature accelerates the decomposition of BF_4^- , especially near the boiling point of the solvent.⁶⁵ Previously titanium dioxide was synthesised in the presence of BF_4^- at 130 °C, allowing for the facile production of F^- .²⁶ It appears that in the synthetic method reported here, the release of F^- is kinetically controlled by the lower temperature of the reaction. If the rate of fluoride formation is significantly slower than the rate of titanium dioxide condensation, the early-stage formation of titanium dioxide will take place in an effectively “fluoride-free” environment.

The presence of rutile and brookite in some materials suggests that during the initial stage of titania formation there is insufficient free fluoride present in solution to ensure complete anatase formation. Non-anatase content appears to increase as anion and cation mass increase. This suggests that PF_6^- decays at a slower rate than BF_4^- , and that the presence of NBu_4^+ as a cation similarly retards the rate of decay.

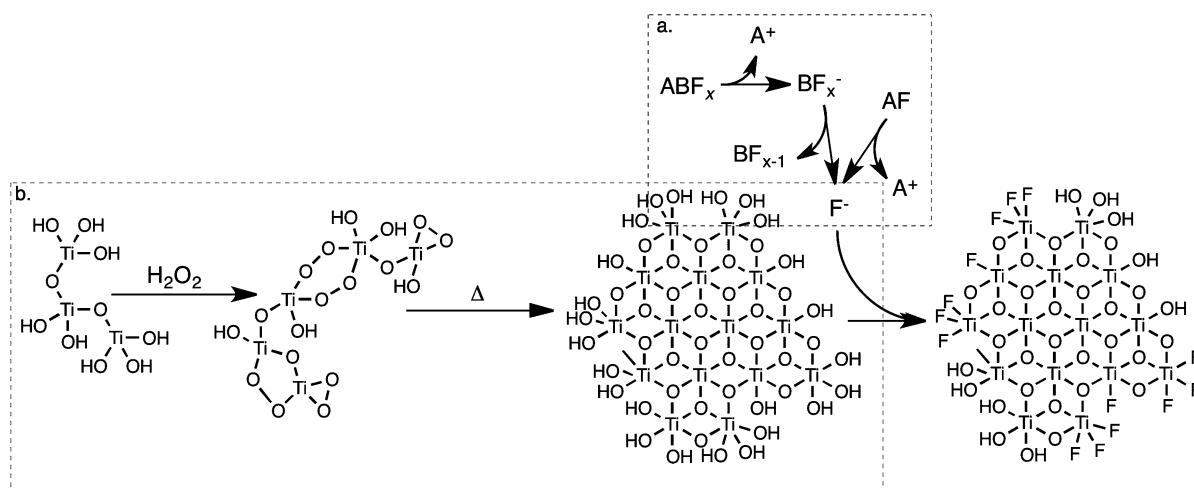


Fig. 12 A proposed mechanism for the formation of fluoride-modified TiO_2 in solution. F^- is formed by the dissolution (and hydrolysis) of fluoride salts (a), while nuclei of titanium dioxide simultaneously form by the breakdown of peroxotitanic acid (b). F^- will then chemisorb to the surface of titanium dioxide, dictating its growth.



3 Experimental

Titanium isopropoxide ($\geq 98\%$, Acros Organics), tetrabutylammonium fluoride (1 M in THF, Acros), ammonium tetrafluoroborate ($\geq 97\%$, Sigma-Aldrich), ammonium hexafluorophosphate ($\geq 95\%$, Sigma), tetrabutylammonium hexafluorophosphate ($\geq 98\%$, Sigma), ammonium fluoride ($\geq 98\%$, BDH), and tetrabutylammonium tetrafluoroborate ($\geq 99\%$, Strem) were all used as supplied, without further purification. P25-TiO₂ "Aeroxide" was manufactured by Evonik Degussa GmbH. Titania particles are 80 : 20 anatase to rutile phase, with a quoted average particle size of 30 nm and surface area of 50 m² g⁻¹.

3.1 Synthesis

Titanium dioxide was synthesised by thermal degradation of peroxotitanic acid.⁶⁶ Titanium isopropoxide precursor (1.78 g, 6.27 mmol) was dissolved in ethanol (5 mL) in a 50 mL round-bottom flask with stirring. Milli-Q water (25 mL) was rapidly added with vigorous stirring to the resulting solution at room temperature. This resulted in the rapid hydrolysis of titanium isopropoxide to produce hydrated titanium dioxide, in the form of an opaque white precipitate. The mixture was magnetically stirred (600 rpm) for a further ten minutes to ensure complete hydrolysis, and the precipitate was then collected by centrifugation (5 min at 5000 rpm) and washed several times with Milli-Q water (by repeated redispersion using Vortex agitator followed by centrifugation as before) to remove ethanol and isopropanol formed during hydrolysis. The titanium dioxide powder was redispersed in water (50 mL) and combined with fluoride salt. The following salts were used: ammonium fluoride (NH₄F), ammonium tetrafluoroborate (NH₄BF₄), ammonium hexafluorophosphate (NH₄PF₆), tetrabutylammonium fluoride (NBu₄F), tetrabutylammonium tetrafluoroborate (NBu₄BF₄), and tetrabutylammonium hexafluorophosphate (NBu₄PF₆). Salts were added in a 1 : 1 molar ratio with titanium (assuming complete hydrolysis and retention of the solid material during washing). Hydrogen peroxide (4.26 g 50% w/w, 62.63 mmol) was then added dropwise with rapid stirring. Upon addition of hydrogen peroxide, the previously opaque white solution immediately turned yellow, and over the course of approximately thirty minutes became transparent as the peroxotitanic acid sol formed. The solution was stirred for one hour after the addition of hydrogen peroxide, before being heated to 100 °C with stirring. Heating was maintained for twenty-four hours, during which the transparent yellow solution produced an opaque white or white-yellow solid.

The precipitate was removed from solution by centrifugation (10 min at 5000 rpm) and washed several times with water. For those materials modified by tetrabutylammonium salts, the precipitate was then washed twice with acetonitrile to remove excess tetrabutylammonium salt, followed by a further two washes with water. Finally, products were dried under vacuum to remove remaining solvent.

3.2 Characterisation

Dried products were analysed by powder X-ray diffraction (PXRD) at the Australian Synchrotron. Samples were

prepared by packing finely ground dried TiO₂ powder in 0.3 mm quartz glass capillary tubes (ultrasound was used to pack the powder down to the bottom of the tubes). The capillary tubes were irradiated for 180 seconds and continuously rotated during the measurement. Data were collected with a Mythen detector spanning 80° in 2 θ . Analysis was performed using Topas 4.2 (Bruker ASX). A Rietveld refinement of a NIST standard LaB₆ 660b was used to determine the incident photons wavelength (0.688650 Å) and instrument profile parameters. A Chebyshev 5th degree polynomial background was used. Structural files of anatase, rutile and brookite were fitted to the PXRD patterns, allowing refinement of crystallite size (Lorentzian and Gaussian), strain (Lorentzian and Gaussian), Ti occupancy, thermal parameters, scale, preferential orientation and lattice parameters. In the case of anisotropic crystallites displaying preferential orientation, two phases of the same lattice parameters, thermal parameters and Ti occupancies were fitted with independently refining degrees of preferential orientation and crystallite size. Crystallite sizes were determined by the average weighted breath of a Double-Voigt fit.³⁶

Surface area measurements were performed by BET analysis of N₂ adsorption on the samples, using a Micrometrics ASAP2010. Samples were degassed for three hours at 300 °C under 3 μ m Hg of vacuum.

Scanning electron microscopy (SEM) images were obtained using a Jeol 7000F FE-SEM. Transmission electron microscopy (TEM) images were obtained using a Philips CM-200 TEM. Samples were suspended in ethanol with the help of sonication, and deposited onto 300 mesh Cu TEM grids coated in Formvar carbon. HRTEM image processing was performed using the software package ImageJ. Dynamic light scattering (DLS) and zeta potential measurements were performed using a Microtrac Zetatrak dynamic light scattering instrument.

The materials were analysed by X-ray photoelectron spectroscopy (XPS) and near-edge X-ray absorption fine-edge structure (NEXAFS) on the soft X-ray beamline at the Australian Synchrotron.⁴¹ Samples were dispersed in ethanol and drop-coated onto a silicon wafer prior to measurement.

All XPS measurements were performed using an excitation energy of 825 eV and a pass energy of 10 eV. Data was collected using a SPECS Phoibos 150 hemispherical energy analyser. The background was fitted using a Shirley approximation for all peaks, with pre- and post-peak background simulated using a simple straight-line equation. Binding energies were normalised using the adventitious carbon peak located at 285 eV (assumed to be the most intense C peak when more than one was observed), and intensities were normalised against titanium. In all cases, energy correction was minimal, indicating little to no charging of the material.

NEXAFS was carried out using the same apparatus on the Ti L_{2,3} edge, with an excitation energy ranging from 450 to 485 eV and a pass energy of 50 eV. Total and Auger Electron Yield (TEY and AEY) as well as Fluorescence Yield (FY) spectra were collected for all samples.



4 Conclusions

Titanium dioxide nanoparticles were synthesised by thermal degradation of peroxotitanic acid in the presence of a number of non-toxic, fluoride-containing, surface-modifying agents (SMAs). The chemical nature of both the anion and cation comprising each SMA affects the properties of the synthesised titania. Overall, the particles were highly crystalline with a high Ti^{3+} population and residual Ti-F species at the surface. Additional fluoride-containing species were observed on the surface of the particles: treatment with KOH solution was found to remove these species, chemisorbed Ti-F proved surprisingly resistant to removal *via* this method.

The choice of SMA was found to influence particle shape and size. F^- - and BF_4^- -containing SMAs resulted in the formation of monodisperse, ovoid nanoparticles with exposed (010) and (101) faces, while PF_6^- -containing SMAs systematically favoured formation of much smaller TiO_2 particles, resulting in an increased surface area.

Synchrotron XPS and NEXAFS studies provide the first evidence that *surface-bound* Ti^{3+} content can be systematically controlled by the choice of SMA. These techniques also reveal two novel trends on the effect of both cations and anions on the abundance of Ti^{3+} (*i.e.* $\text{F}^- > \text{BF}_4^- > \text{PF}_6^-$; $\text{NBu}_4^+ > \text{NH}_4^+$). We expect that these properties will lead to increased visible-light activity for the materials due to the creation of intra-band energy levels.

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References

- U. Diebold, *Surf. Sci. Rep.*, 2003, **48**, 53–229.
- X. Hu, G. Li and J. C. Yu, *Langmuir*, 2010, **26**, 3031–3039.
- A. Fujishima and K. Honda, *Nature*, 1972, **238**, 37–38.
- A. Fujishima, X. Zhang and D. Tryk, *Surf. Sci. Rep.*, 2008, **63**, 515–582.
- X. Chen and S. S. Mao, *Chem. Rev.*, 2007, **107**, 2891–2959.
- G. Liu, L. Wang, H. G. Yang, H.-M. Cheng and G. Q. M. Lu, *J. Mater. Chem.*, 2010, **20**, 831–843.
- H. Sun, S. Wang, H. M. Ang, M. O. Tadé and Q. Li, *Chem. Eng. J.*, 2010, **162**, 437–447.
- H. Sun, Y. Bai, Y. Cheng, W. Jin and N. Xu, *Ind. Eng. Chem. Res.*, 2006, **45**, 4971–4976.
- H. G. Yang, C. H. Sun, S. Z. Qiao, J. Zou, G. Liu, S. C. Smith, H.-M. Cheng and G. Q. Lu, *Nature*, 2008, **453**, 638–641.
- R. Asahi, T. Morikawa, T. Ohwaki, K. Aoki and Y. Taga, *Science*, 2001, **293**, 269–271.
- S. Ahmed, M. G. Rasul, R. Brown and M. A. Hashib, *J. Environ. Manage.*, 2011, **92**, 311–330.
- M. A. Henderson, *Surf. Sci. Rep.*, 2011, **66**, 185–297.
- H. Park and W. Choi, *J. Phys. Chem. B*, 2004, **108**, 4086–4093.
- M. V. Dozzi, B. Ohtani and E. Selli, *Phys. Chem. Chem. Phys.*, 2011, **13**, 18217–18227.
- H. G. Yang, G. Liu, S. Z. Qiao, C. H. Sun, Y. G. Jin, S. C. Smith, J. Zou, H.-M. Cheng and G. Q. M. Lu, *J. Am. Chem. Soc.*, 2009, **131**, 4078–4083.
- X. Han, Q. Kuang, M. Jin, Z. Xie and L. Zheng, *J. Am. Chem. Soc.*, 2009, **131**, 3152–3153.
- G. Liu, H. G. Yang, X. Wang, L. Cheng, H. Lu, L. Wang, G. Q. Lu and H.-M. Cheng, *J. Phys. Chem. C*, 2009, **113**, 21784–21788.
- J. Feng, M. Yin, Z. Wang, S. Yan, L. Wan, Z. Li and Z. Zou, *CrystEngComm*, 2010, **12**, 3425.
- X. H. Yang, Z. Li, G. Liu, J. Xing, C. Sun, H. G. Yang and C. Li, *CrystEngComm*, 2011, **13**, 1378–1383.
- A. S. Ichimura, B. M. Mack, S. M. Usmani and D. G. Mars, *Chem. Mater.*, 2012, **24**, 2324–2329.
- N. Liu, Y. Zhao, X. Wang, H. Peng and G. Li, *Mater. Lett.*, 2013, **102–103**, 53–55.
- L. Wu, B. X. Yang, X. H. Yang, Z. G. Chen, Z. Li, H. J. Zhao, X.-Q. Gong and H. G. Yang, *CrystEngComm*, 2013, **15**, 3252.
- D. Zhang, G. Li, X. Yang and J. C. Yu, *Chem. Commun.*, 2009, 4381–4383.
- J. Yu, Q. Xiang and J. R. S. Mann, *CrystEngComm*, 2010, **12**, 872–879.
- C. Cai, J. Wang, F. Cao, H. Li and J. Zhu, *Chin. J. Catal.*, 2011, **32**, 862.
- Z. Lai, F. Peng, Y. Wang, H. Wang, H. Yu, P. Liu and H. Zhao, *J. Mater. Chem.*, 2012, **22**, 23906.
- K. Lv, J. Yu, J. Fana and M. Jaroniec, *CrystEngComm*, 2011, **13**, 7044–7048.
- X. Zhou, F. Peng, H. Wang, H. Yu and Y. Fang, *Chem. Commun.*, 2012, **48**, 600–602.
- J. Zhu, S. Wang, Z. Bian, S. Xie, C. Cai, J. Wang, H. Yang and H. Li, *CrystEngComm*, 2010, **12**, 2219–2224.
- D. Wu, Z. Gao, F. Xu, J. Chang, S. Gao and K. Jiang, *CrystEngComm*, 2012, **15**, 516.
- W. Wang, C. Lu, Y. Ni and Z. Xu, *CrystEngComm*, 2013, **15**, 2537.
- L. Zhou, J. Chen, C. Ji, L. Zhou and P. O'Brien, *CrystEngComm*, 2013, **15**, 5012.
- X. Ding, H. Ruan, C. Zheng, J. Yang and M. Wei, *CrystEngComm*, 2013, **15**, 3040.
- W. Wang, C. Lu, Y. Ni, F. Peng and Z. Xu, *Appl. Surf. Sci.*, 2012, 1–5.



- 35 J. C. Yu, J. Yu, W. Ho, Z. Jiang and L. Zhang, *Chem. Mater.*, 2002, **17**, 3808–3816.
- 36 D. Balzar, *Microstructure Analysis from Diffraction*, International Union of Crystallography, 1999.
- 37 B. A. Morales, O. Novaro, T. Lopez, E. Sanchez and R. Gomez, *J. Mater. Res.*, 1995, **10**, 2788–2796.
- 38 C. Ribeiro, C. Vila, D. B. Stroppa, V. R. Mastelaro, J. Bettini, E. Longo and E. R. Leite, *J. Phys. Chem. C*, 2007, **111**, 5871–5875.
- 39 W.-J. Li, E.-W. Shi and Z.-W. Yin, *J. Cryst. Growth*, 2000, **208**, 546–554.
- 40 J. Pan, G. Liu, G. Q. M. Lu and H.-M. Cheng, *Angew. Chem., Int. Ed.*, 2011, **50**, 2133–2137.
- 41 B. C. C. Cowie, A. Tadic and L. Thomsen, *AIP Conf. Proc.*, 2010, **1234**, 307–310.
- 42 Z. He, Q. Cai, F. Hong, Z. Jiang, J. Chen and S. Song, *Ind. Eng. Chem. Res.*, 2012, **51**, 5662–5668.
- 43 Q. Wang, C. Chen, D. Zhao, W. Ma and J. Zhao, *Langmuir*, 2008, **24**, 7338–7345.
- 44 T. K. Le, D. Flahaut, H. Martinez, T. Pigot, H. K. H. Nguyen and T. K. X. Huynh, *Appl. Catal., B*, 2014, **144**, 1–11.
- 45 D. Li, H. Haneda, S. Hishita and N. Ohashi, *Chem. Mater.*, 2005, **17**, 2588–2595.
- 46 J. F. Moulder, W. F. Stickle, P. E. Sobol and K. D. Bomben, *Handbook of X-ray Photoelectron Spectroscopy*, Physical Electronics Limited, Minnesota, 1995.
- 47 Q. Xiang, K. Lv and J. Yua, *Appl. Catal., B*, 2010, **96**, 557–564.
- 48 Y. Kim, B. J. Yoo, R. Vittal, Y. Lee, N.-G. Park and K.-J. Kim, *J. Power Sources*, 2008, **175**, 914–919.
- 49 X. Zhang, H. Tian, X. Wang, G. Xue, Z. Tian, J. Zhang, S. Yuan, T. Yu and Z. Zou, *Mater. Lett.*, 2013, **100**, 51–53.
- 50 S. Song, J. Tu, Z. He, F. Hong, W. Liu and J. Chen, *Appl. Catal., A*, 2010, **378**, 169–174.
- 51 S. A. Tenney, B. A. Cagg, M. S. Levine, W. He, K. Manandhar and D. A. Chen, *Surf. Sci.*, 2012, **606**, 1233–1243.
- 52 G. Liu, J. A. Rodriguez, J. Hrbek, B. T. Long and D. A. Chen, *J. Mol. Catal. A: Chem.*, 2003, **202**, 215–227.
- 53 G. G. Fuentes, E. Elizalde, F. Yubero and J. M. Sanz, *Surf. Interface Anal.*, 2002, **33**, 230–237.
- 54 T. Kako, N. Umezawa, K. Xie and J. Ye, *J. Mater. Sci.*, 2013, **48**, 108–114.
- 55 F. Zuo, L. Wang, T. Wu, Z. Zhang, D. Borchardt and P. Feng, *J. Am. Chem. Soc.*, 2010, **132**, 11856–11857.
- 56 J. P. Crocombette and F. Jollet, *J. Phys.: Condens. Matter*, 1994, **6**, 10811–10821.
- 57 R. Ruus, A. Kikas, A. Saar, O. A. Ausmees, E. Ndmiste, J. Aarik, A. Aidla, T. Uustare and I. Martinson, *Solid State Commun.*, 1997, **104**, 199–203.
- 58 M. Cheynet, S. Pokrant, S. Irsen and P. Krüger, *Ultramicroscopy*, 2010, **110**, 1046–1053.
- 59 G. S. Henderson, X. Liu and M. E. Fleet, *Phys. Chem. Miner.*, 2002, **29**, 32–42.
- 60 S. J. Stewart, M. Fernández-García, C. Belver, B. S. Mun and F. G. Requejo, *J. Phys. Chem. B*, 2006, **110**, 16482–16486.
- 61 J. Stöhr, *NEXAFS Spectroscopy*, Springer, Berlin, 1st edn, 2003.
- 62 F. De Groot, M. O. Figueiredo, M. J. Basto, M. Abbate, H. Petersen and J. C. Fuggle, *Phys. Chem. Miner.*, 1992, **19**, 140–147.
- 63 Z. Miao, Z. Liu, K. Ding, B. Han, S. Miao and G. An, *Nanotechnology*, 2007, **18**, 125605.
- 64 P. J. Dyson and T. J. Geldbach, *Metal Catalysed Reactions in Ionic Liquids*, Springer, Dordrecht, 2005.
- 65 D. S. Jacob, L. Bitton, J. Grinblat, I. Felner, Y. Koltypin and A. Gedanken, *Chem. Mater.*, 2006, **18**, 3162–3168.
- 66 N. Sasirekha, B. Rajesh and Y.-W. Chen, *Thin Solid Films*, 2009, **518**, 43–48.

